Application/Control No.	Applicant(s)/Patent under Reexamination	
09/944,106	LIEBL ET AL.	
Examiner	Art Unit	

Jungwon Chang

2154

	SEARCHED				
Class	Subclass	Date	Examiner		
701	29	3/18/2006	JWC		
702	183	3/18/2006	JMC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
701	29	3/18/2006	JWC	
702	183	3/18/2006	JMC	
345	472	3/18/2006	JWC	
701/23,29,33		3/18/2006	JWC	

SEARCH (INCLUDING SEAI		<b>'</b> )
	DATE	EXMR
East ACM Google Search report attached	3/18/2006	JMC
Inventor name search	3/18/2006	JWC
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